

## SILICON TRANSISTOR ARRAY

# $\mu$ PA1478

## NPN SILICON POWER TRANSISTOR ARRAY LOW SPEED SWITCHING USE (DARLINGTON TRANSISTOR) INDUSTRIAL USE

#### **DESCRIPTION**

The  $\mu$ PA1478 is NPN silicon epitaxial Darlington Power Transistor Array that built in Surge Absorber and 4 circuits designed for driving solenoid, relay, lamp and so on.

#### **FEATURES**

- · Surge Absorber (Zener Diode) built in.
- · Easy mount by 0.1 inch of terminal interval.
- · High hee for Darlington Transistor.

#### ORDERING INFORMATION

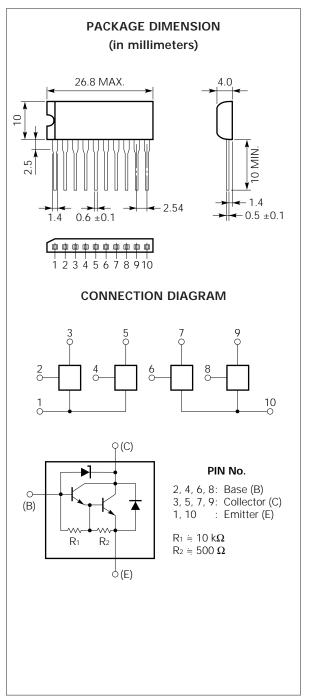
Part Number	Package	Quality Grade		
μPA1478H	10 Pin SIP	Standard		

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Collector to Base Voltage	Vсво	31 ±4	V
Collector to Emitter Voltage	VCEO	31 ±4	V
Emitter to Base Voltage	$V_{EBO}$	7	V
Surge Sustaining Energy	Eceo (sus)	40	mJ/unit
Collector Current (DC)	Ic(DC)	±2	A/unit
Collector Current (pulse)	Ic(pulse)*	±4	A/unit
Total Power Dissipation	P <sub>T1</sub> **	3.5	W
Total Power Dissipation	P <sub>T2</sub> ***	28	W
Junction Temperature	TJ	150	.C
Storage Temperature	Tstg -	-55 to +15	0 °C

- \* PW  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  10 %
- \*\* 4 Circuits, Ta = 25 °C
- \*\*\* 4 Circuits, Tc = 25 °C



The information in this document is subject to change without notice.

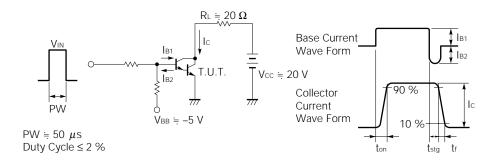


## ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Collector Leakage Current	Ісво			10	μΑ	Vcb = 20 V, IE = 0	
Emitter Leakage Current	Іево			1	mA	V <sub>EB</sub> = 5 V, I <sub>C</sub> = 0	
Collector to Emitter Sustaining Voltage	Vceo(sus)	27	31	35	V	Ic = 1 A, L = 3 mH	
DC Current Gain	h <sub>FE1</sub> *	1000			_	Vce = 2 V, Ic = 0.5 A	
DC Current Gain	h <sub>FE2</sub> *	2000		30000	_	Vce = 2 V, Ic = 1 A	
Collector Saturation Voltage	VCE(sat) *			1.5	V	Ic = 1 A, I <sub>B</sub> = 1 mA	
Base Saturation Voltage	V <sub>BE(sat)</sub> *			2	V	Ic = 1 A, IB = 1 mA	
Turn On Time	ton		0.5		μs	Ic = 1 A	
Storage Time	tstg		3		μs	$\label{eq:BB} \begin{array}{l} I_{B1} = -I_{B2} = 1 \text{ mA} \\ V_{CC} \doteqdot 20 \text{ V, } R_L \doteqdot 20 \Omega \\ \text{See test circuit} \end{array}$	
Fall Time	tf		1		μs		

<sup>\*</sup> PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2 % / pulsed

### SWITCHING TIME TEST CIRCUIT

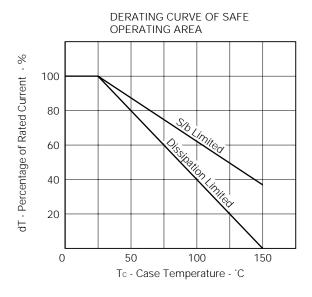


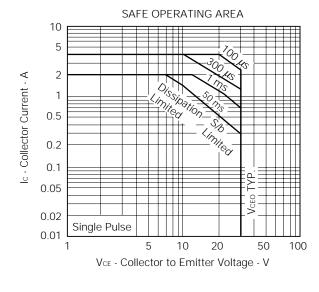
The application circuits and their parameters are for references only and are not intended for use in actual design-in's.

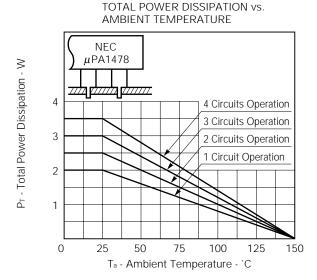
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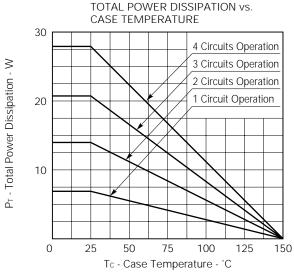


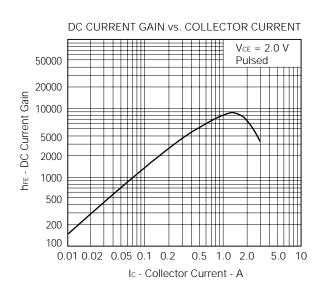
#### TYPICAL CHARACTERISTICS (TA = 25 °C)

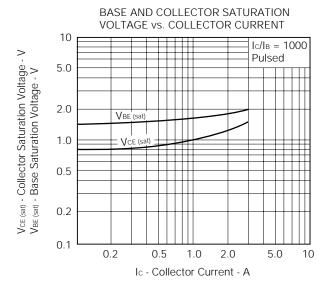




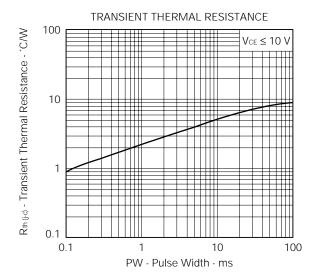


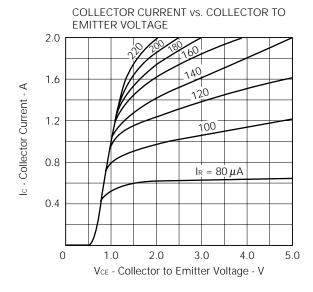














# REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system.	TEI-1202
Quality grade on NEC semiconductor devices.	IEI-1209
Semiconductor device mounting technology manual.	IEI-1207
Semiconductor device package manual.	IEI-1213
Guide to quality assurance for semiconductor devices.	MEI-1202
Semiconductor selection guide.	MF-1134

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